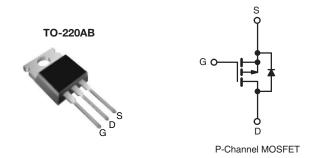


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 100			
R _{DS(on)} (Ω)	V _{GS} = - 10 V 0.20			
Q _g (Max.) (nC)	61			
Q _{gs} (nC)	14			
Q _{gd} (nC)	29			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF9540PbF		
Lead (FD)-life	SiHF9540-E3		
SnPb	IRF9540		
SIFD	SiHF9540		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V_{DS}	- 100	V		
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at - 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	l _D	- 19		
Continuous Drain Current	$T_C = 100 ^{\circ}$		- 13	Α	
Pulsed Drain Current ^a	I_{DM}	- 72			
Linear Derating Factor		1.0	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	640	mJ		
Repetitive Avalanche Current ^a	I _{AR}	- 19	Α		
Repetitive Avalanche Energy ^a	E _{AR}	15	mJ		
Maximum Power Dissipation	T _C = 25 °C	P_{D}	150	W	
Peak Diode Recovery dV/dtc	dV/dt	- 5.5	V/ns		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Manualina Tana	0.00 - 110 - 11	•	10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw		1.1	N·m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25$ V, starting $T_J = 25$ °C, L = 2.7 mH, $R_g = 25$ Ω , $I_{AS} = -19$ A (see fig. 12).
- c. $I_{SD} \le$ 19 A, $dI/dt \le$ 200 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 1\bar{7}5$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V _{GS} = 0 V, I _D = - 250 μA		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = - 1 mA	-	- 0.087	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V	_{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		100 V, V _{GS} = 0 V V _{GS} = 0 V, T _J = 150 °C	-	-	- 100 - 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{DS} = -80 \text{ V},$ $V_{GS} = -10 \text{ V}$	I _D = - 11 A ^b		_	0.20	Ω
Forward Transconductance			50 V, I _D = - 11 A ^b	6.2	_	-	S
Dynamic	9fs	VDS	50 V, ID = - 11 A	0.2			3
Input Capacitance	C _{iss}			_	1400		
Output Capacitance	C _{oss}		$V_{GS} = 0 \text{ V},$ $V_{GS} = -25 \text{ V},$	_	590	_	pF
Reverse Transfer Capacitance	C _{rss}		MHz, see fig. 5	_	140	_	Pi
Total Gate Charge	Q _g			_	-	61	
Gate-Source Charge	Q _{gs}	Voc = - 10 V	$V_{GS} = -10 \text{ V}$ $I_D = -19 \text{ A}, V_{DS} = -80 \text{ V},$ see fig. 6 and 13 ^b $V_{DD} = -50 \text{ V}, I_D = -19 \text{ A},$ $R_g = 9.1 \Omega, R_D = 2.4 \Omega,$ see fig. 10 ^b		_	14	nC
Gate-Drain Charge	Q _{gd}	- VGS - 10 V			_	29	
Turn-On Delay Time	t _{d(on)}				16	-	
Rise Time	t _r	-			73	_	- ns
Turn-Off Delay Time	t _{d(off)}	$V_{DD} = -$ $R_g = 9.1 \Omega, F$			34	-	
Fall Time	t _f			_	57	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") fro	Between lead, 6 mm (0.25") from		4.5	-	
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 19	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 72	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = -19 A, V _{GS} = 0 V ^b		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 19 A, dI/dt = 100 A/μs ^b		-	130	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.35	0.70	μC
Forward Turn-On Time	t _{on}	Intrinsic turi	irn-on is dominated by L _S and L _D)			L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

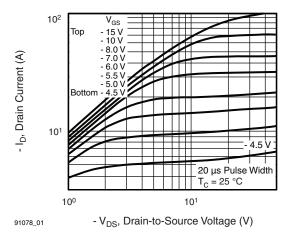


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

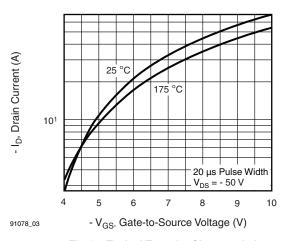


Fig. 3 - Typical Transfer Characteristics

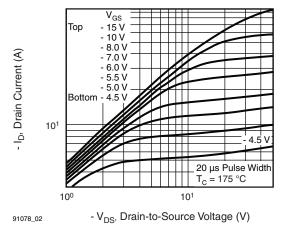


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}$ C

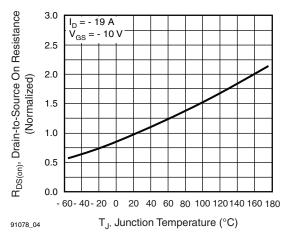


Fig. 4 - Normalized On-Resistance vs. Temperature



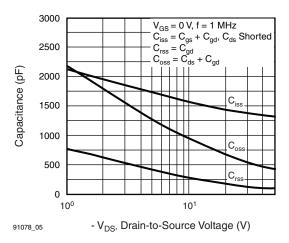


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

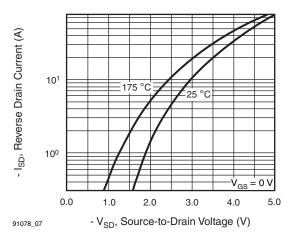


Fig. 7 - Typical Source-Drain Diode Forward Voltage

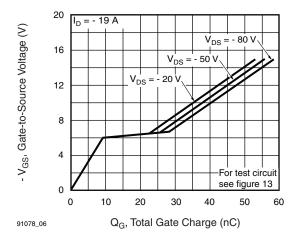


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

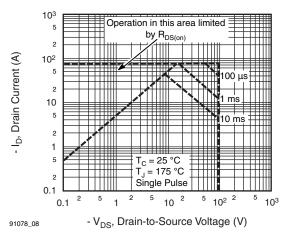


Fig. 8 - Maximum Safe Operating Area



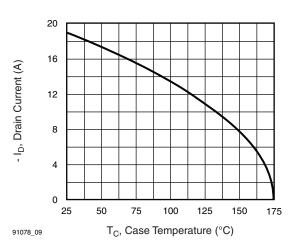


Fig. 9 - Maximum Drain Current vs. Case Temperature

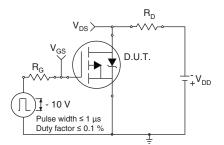


Fig. 10a - Switching Time Test Circuit

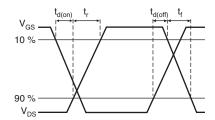


Fig. 10b - Switching Time Waveforms

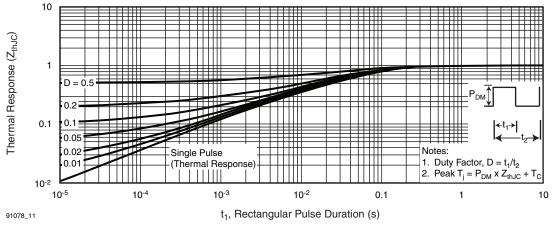


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



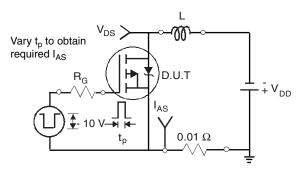


Fig. 12a - Unclamped Inductive Test Circuit

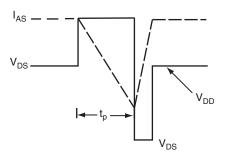


Fig. 12b - Unclamped Inductive Waveforms

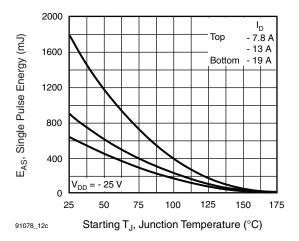


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

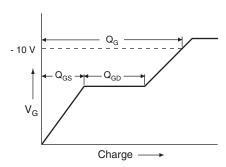


Fig. 13a - Basic Gate Charge Waveform

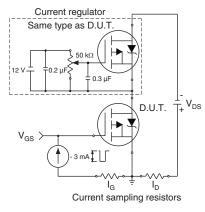
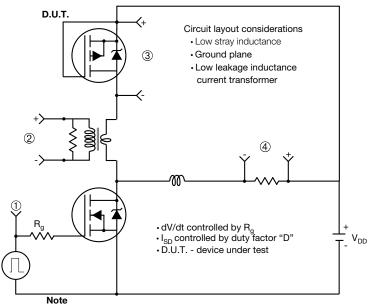


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

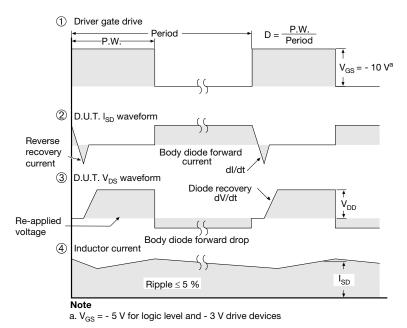


Fig. 14 - For P-Channel

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TO-220-1



DIM.	MILLIM	IETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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